Bilateral Comparison of 1.018 V and 10 V Standards between the BEV, Austria and the BIPM, April 2001

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A comparison of the 1.018 V and 10 V voltage reference standards of the BIPM and the Bundesamt für Eich- und Vermessungswesen(BEV, Vienna, Austria) was carried out in April 2001. Two BIPM 732B Zener diode-based travelling standards, BIPM8 and BIPM9, were transported by freight. The BIPM and BEV measurements were carried out at 1.018 V and 10 V using the Josephson array voltage standard of the laboratory. Results of all measurements were corrected for the dependence of the output voltage on ambient temperature and pressure.

Figures 1 and 2 show the measured values obtained for the two standards by the two laboratories. The values and uncertainties were calculated for the reference date from linear least-squares fits.

Table 1 lists the results of the 1.018 V comparison and the contributions to the uncertainty budget. Experience has shown that flicker or 1/f noise dominates the stability characteristics of Zener-diode standards and it is not appropriate to use the standard deviation of the mean to characterize the dispersion of measured values. For the present standards, the relative value of the flicker floor voltage is about 1 part in 10^8 .

Table 2 lists the same information for the 10 V comparison.

In estimating the uncertainty we calculated the *a priori* uncertainty based on all known sources except that associated with the stability of the standards when transported, and compared this with the *a posteriori* uncertainty estimated by the standard deviation of the mean of the results from the two travelling standards. With only two travelling standards, the uncertainty of the standard deviation of the mean is comparable to the value of the standard deviation of the mean itself. If the *a posteriori* uncertainty is significantly different from the *a priori* uncertainty, we assume that a standard has changed in an unusual way and we used the larger of these two estimates in calculating the final uncertainty.

In Table 1 and 2, the following elements are listed:

- (1) the predicted value U_{Z_BEV} of each Zener, computed using a linear least squares fit to all of the data from the BEV and referenced to the mean date of the BEV's measurements;
- (2) the Type A uncertainty arising from instability of the Zener, computed as the standard uncertainty of the predicted value from the linear drift model, or an estimate of the 1/f noise voltage level;
- (3) the uncertainty component arising from the measuring equipment of the BEV. This uncertainty is completely correlated between the different Zeners used for a comparison;
- (4-6) the corresponding quantities for the BIPM;
- (7) the uncertainty due to the combined effects of the uncertainties of the pressure and temperature coefficients and to the difference of the mean pressures and temperatures in the participating laboratories; although the same equipment is used to measure the coefficients for all Zeners, the uncertainty is dominated by the Type A uncertainty of each Zener, so that the final uncertainty can be considered as uncorrelated among the different Zeners used in a comparison;
- (8) the difference $(U_{Z \text{ BEV}} U_{Z \text{ BIPM}})$ for each Zener, and
- (9) the uncorrelated part of the uncertainty;
- (10) the result of the comparison, which is the mean of the differences of the calibration results for the different standards;

the uncertainty of the transfer, estimated by two methods;

- (11) the *a priori* uncertainty, which is the standard deviation of the mean value of the results from the different Zeners, counting only the uncorrelated uncertainties of the individual results;
- (12) the *a posteriori* uncertainty, which is the standard deviation of the mean of the different results;
- (13) the correlated part of the uncertainty;

and

(14) the total uncertainty of the comparison, which is the root-sum-square of the correlated part of the uncertainty and of the larger of (11) and (12).

Table 3 and 4 summarize the uncertainties due to the measuring equipment of the BEV and of the BIPM, respectively.

The final results of the comparison are presented as the differences between the values assigned to a 1.018 V and a 10 V standard by each laboratory. The difference between the value assigned by the BEV at the BEV, $U_{\rm BEV}$, and that assigned by the BIPM at the BIPM, $U_{\rm BIPM}$, for a 1.018 V standard on the reference date is

$$U_{\text{BEV}(1.018 \text{ V})} - U_{\text{BIPM}(1.018 \text{ V})} = -0.013 \text{ }\mu\text{V}; u_c = 0.017 \text{ }\mu\text{V} \text{ on } 2001/04/12,$$

where u_c is the combined standard uncertainty, and for a 10 V standard on the reference date is

$$U_{\text{BEV}(10 \text{ V})} - U_{\text{BIPM}(10 \text{ V})} = -0.04 \text{ }\mu\text{V}; u_{\text{c}} = 0.10 \text{ }\mu\text{V} \text{ on } 2001/04/12.$$

These are very satisfactory results. In both cases the difference between the values assigned to the travelling standards by the two laboratories is less than the standard uncertainty associated with the difference.

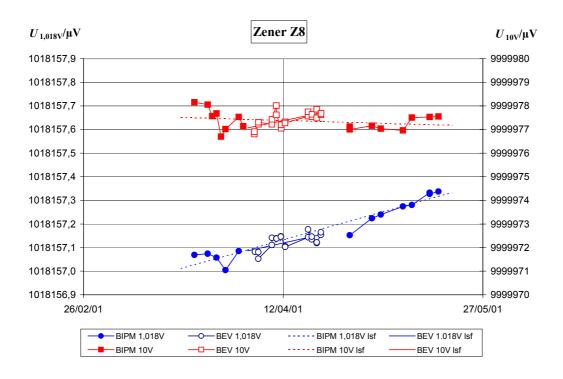


Figure 1. Voltage of BIPM8 as a function of time, with linear least-squares fits to the measurements in each laboratory

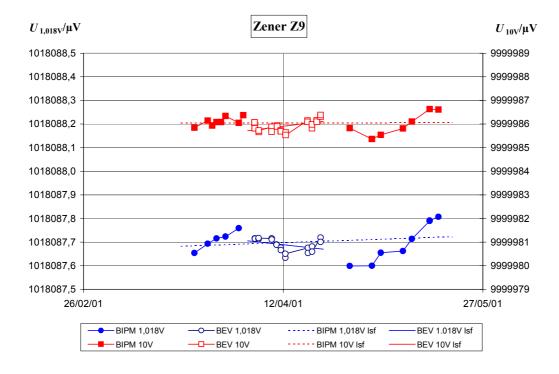


Figure 2. Voltage of BIPM9 as a function of time, with linear least-squares fits to the measurements in each laboratory

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Table 1. Results of the BEV(Austria)/BIPM bilateral comparison of 1.018 V standards using two Zener travelling standards: reference date 12 April 2001. Uncertainties are 1 σ estimates. The uncorrelated uncertainty is $w = [r^2 + t^2 + v^2]^{1/2}$, the expected transfer uncertainty is $x = [w_8^2 + w_9^2]^{1/2}/2$ and the correlated uncertainty is $y = [s^2 + u^2]^{1/2}$.

		BIPM8	BIPM9	
1	$BEV (Austria)(U_{Z_BEV} - 1.018 \text{ V})/\mu\text{V}$	157.123	87.687	
2	Type A uncertainty/μV	0.010	0.010	r
3	equipment uncertainty/μV	0.007		S
4	$BIPM$ $(U_{Z_BIPM} - 1.018 \text{ V})/\mu\text{V}$	157.137	87.698	
5	Type A uncertainty/μV	0.010	0.022	t
6	equipment uncertainty/μV	0.005		u
7	pressure and temperature corrections uncertainty/µV	0.002	0.005	v
8	$(U_{\rm Z_BEV} - U_{\rm Z_BIPM})/\mu { m V}$	-0.014	-0.011	
9	uncorrelated uncertainty/μV	0.014	0.025	w
10	$< U_{ m BEV} - U_{ m BIPM} > /\mu m V$	-0.	013	
11	expected transfer uncertainty/ μV	0.	014	x
12	$s_{\rm M}$ of difference for 2 Zeners/ μV	0.	001	
13	correlated uncertainty/µV	0.	009	y
14	comparison total uncertainty/μV	0.	017	

Table 2. Results of the BEV(Austria)/BIPM bilateral comparison of 10 V standards using two Zener travelling standards: reference date 12 April 2001. Uncertainties are 1 σ estimates. The uncorrelated uncertainty is $w = [r^2 + t^2 + v^2]^{1/2}$, the expected transfer uncertainty is $x = [w_8^2 + w_9^2]^{1/2}/2$ and the correlated uncertainty is $y = [s^2 + u^2]^{1/2}$.

		BIPM8	BIPM9	
1	BEV (Austria) $(U_{Z BEV} - 10 \text{ V})/\mu\text{V}$	-22.59	-14,02	
2	Type A uncertainty/μV	0.10	0.10	r
3	equipment uncertainty/μV	0.01		S
4	$BIPM$ $(U_{Z_BIPM} - 10 \text{ V})/\mu\text{V}$	-22.62	-13.91	
5	Type A uncertainty/μV	0.10	0.10	t
6	equipment uncertainty/μV	0.01		u
7	pressure and temperature corrections uncertainty/µV	0.01	0.02	v
8	$(U_{\rm Z_BEV} - U_{\rm Z_BIPM})/\mu { m V}$	0.03	-0.11	
9	uncorrelated uncertainty/μV	0.14	0.14	w
10	$< U_{ m BEV} - U_{ m BIPM} > /\mu m V$	-0.04		
11	expected transfer uncertainty/µV	0.10		x
12	$s_{\rm M}$ of difference for 2 Zeners/ μV	0.07		
13	correlated uncertainty/µV	0.	01	У
14	comparison total uncertainty/μV	0.	10	

Table 3: estimated standard uncertainties for Zener calibrations with the BEV equipment. The uncertainties due to the detector and to the electromagnetic interference (EMI) are considered to be already contained in the type A uncertainty of the results.

	Uncertainty/nV	
	1.018 V	10 V
thermistor measurement	3.1	2
pressure measurement	1.2	12
thermal electromotive forces	2.9	3
detector/EMI	0.0	0
leakage resistance	5.8	3
frequency	0.1	1
total	7.3	12

Table 4: estimated standard uncertainties for Zener calibrations with the BIPM equipment.

	Uncertainty/nV	
	1.018 V	10 V
thermistor measurement	1.6	1
pressure measurement	0.4	4
thermal electromotive forces	3.0	3
detector/EMI	3.0	1
leakage resistance	3.0	0
frequency	0.0	0
total	5.5	5